Search Notes



Application/Control No.

10662470 Examiner

Ho, Huy C

Applicant(s)/Patent Under Reexamination

EKBERG, JAN-ERIK

Art Unit

2617

	SEARCHED

Class	Subclass	Date	Examiner
370	338	5/25/07	HH

SEARCH NOTES

SEARGH NOTES				
Search Notes	Date	Examiner		
EAST search in USPAT, US PGPUB, USOCR, JPO, DERWENT, IBM(See	1/18/07	HH		
attached search strategy				
Search update	5/25/07	HH		
Search update	11/25/2007	HH		
Search update	5/19/2008	HH		
Search update	12/30/2008	HH		
Consulted with SPE Nick Corsaro	12/30/2008	HH		
Consulted with SPE Alexander Eisen	1/14/2009	HH		
Search update	3/26/2009	HH		

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	41.2	12/30/2008	HH
709	227	3/26/2009	HH

/Huy C Ho/ Examiner, Art Unit 2617

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